

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10710279	GUENOUN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Singh, Hirdepal	2611

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	215	6/28/07	HS
375	226	6/28/07	HS
375	243	6/28/07	HS
375	326-327	6/28/07	HS
375	355-357	6/28/07	HS
375	371-376	6/28/07	HS
327	146-150	6/28/07	HS
327	156	6/28/07	HS
375	215	8/29/07	HS
375	226	8/29/07	HS
375	243	8/29/07	HS
375	326-327	8/29/07	HS
375	355-357	8/29/07	HS
375	371-376	8/29/07	HS
327	146-150	8/29/07	HS
327	156	8/29/07	HS

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
US-PG PUB; USPAT; USOCR; FPRS; EPO; JPO; IBM_TDB; DERWENT	6/28/2007	HS
US-PG PUB; USPAT; USOCR; FPRS; EPO; JPO; IBM_TDB; DERWENT	8/29/07	HS
PLUS SEARCH	8/29/07	HS
GOOGLE SEARCH	8/29/07	HS
IEEE EXPLORE	8/29/07	HS
Shuwang Liu (SPE-2611)	8/29/07	HS

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	327	8/29/07	HS
375	354	8/29/07	HS
375	371	8/29/07	HS
375	376	8/29/07	HS